Recent Pb-free Electronic Packaging Issues

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Outline

- World Wide Environmental Regulation Status
- World Wide Pb-free Activities
- Key items in Pb-free Technology
- Challenging of Pb-free materials
 - > Solder ball/solder paste
 - > Electroplating systems
- Examples of Pb-free solder developed
- Roadblocks for Pb-free Transition
- Summary

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Design for Environment (DFE)

- Materials of concern
 - → Reduction
 - → Elimination / substitution
- Design for disassembly and reuse
 - → Assembly technology and materials
 - > Reduction in number of materials used
 - → Reduction in use of coatings and other inseparable materials configurations
- Volume reduction
 - → Manufacturing
 - → Products (EOL disposition)

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Pending Legislation in Europe

- European Parliament adopted the proposal of Restriction on Hazardous Substances (RoHS)/WEEE on May 15, 2001
- RoHS bans cover:

Lead, Mercury, Cadmium & Hex. Chromium PBB and PBDE fire retardants

- Proposed implementation: January 2006
- Lead is the most frequently used metal on the list
 - → At least 200,000 electronic products and at least 200,000 sub-assemblies will be affected -but mission critical
- A limited number of exemptions
 - → Lead contained in high melting temperature type solder
 - → Lead in glass in electronic components
 - → Lead in piezoelectric devices
 - → Lead in servers, storage and storage, array systems, voice and data transmission and networking equipment

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WSC Recommended Statement

- Industry is working to develop lead free technology
- Development of "lead free" compatible components is a massive effort
- Industry must work together to establish standards
- Converting the industry to totally "lead free" products will take many years and for some products may not be possible
- EU timescale is very aggressive for total product & industry conversion
- Exemptions will be required to assure product reliability for consumers
- We must also be clear with governments that "lead free" products have lead free solder paste, may or may not have lead free components

From 5th World Semiconductor Council Meeting held in Okinawa, May 2001

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World Wide Environmental Regulation

- OECD tightens regulation for Pb concentration in subterranean water (0.025mg/L from 2000)
- Denmark Ban on usage of Pb in metal or substance
 Statutory order No.1012 of Nov. 13, 2000, On Prohibition of import and marketing of Products containing LEAD.
- US EPA TRI (Toxics Release Inventory) activated in 2001.
 Any company that uses 100 pounds of Pb must file an annual report to EPA.
- JAPAN

MITI take-back legislation
Appliance recycling bill in full force by April 2001
*MITI (Ministry of International Trade and Industry)

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Appliance Recycling Bill Specific Home Electronics Recycling Law From April 1st in 2001 Collection, reuse and recycling Basic requirement for recycling Air conditioner : 60 % TV : 55 % : 50 % Refrigerator Washing machine : 50 % Waste Treatment After collection of waste electronics, We need suitable treatment not to release Pb into the environment.. PWB of TV must be treated separately? Source,: SEMI 2000 Current Lead-Free Soldering in Japan, Katsuaki Suganuma, ISIR, Osaka University

Lead

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Lead can cause damage to both the central and peripheral nervous systems of humans.

Effects on the endocrine system have also been observed. In addition, lead can have negative effects on the blood system and the kidneys.

Lead accumulates in the environment and has high acute and chronic toxic effects on plants, animals and micro-organisms.

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Compare Risk Reduction Monograph No 1 Lead Background and national experience with reducing risk, OECD Paris 1993.

Under Council Directive 67/548/EEC on the classification and labelling of dangerous substances as amended lead compounds are classified:

OJ L 196, 16/08/1967, p. 1.

- R20/22 Harmful by inhalation and if swallowed
- R33 Danger of cumulative effects.

The relative importance of any single source of exposure is difficult to predict and will vary with geographic location, climate and local geochemistry. In any case, consumer electronics constitute 40% of lead found in landfills. The main concern in regard to the presence of lead in landfills is the potential for the lead to leach and contaminate drinking water supplies

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Recycling of WEEE

One of the main objectives of the present initiative is to increase the recycling of WEEE. In general, increased recycling saves resources and capacities of disposal, in particular landfill. In spite of the positive effects, the recovery operation might add to environmental pollution if the waste is not properly pre-treated.

Due to plastics containing halogenated substances, both dioxins and furans are generated as a consequence of recycling the metal content of WEEE. Halogenated substances contained in WEEE, in particular brominated flame retardants, are also of concern during the extrusion of plastics, which is part of the plastic recycling. Due to the risk of generating dioxins and furans, recyclers usually abstain from recycling flame retarded plastics from WEEE. In view of the lack of proper identification of plastic containing flame retardents and inherent difficulty to distinguish flame retardetretardant plastic from ordinary plastic most of the recyclers do not process any plastic from WEEE.

As an example, the case of the metal reclamation plant Brixlegg/Austria (Comparison of PCDD/PCDF levels in soil, grass, cows milk, human blood and spruce needles in an area of PCDD/PCDF contamination through emissions from a metal reclamation plant Riss, Hagenmaier, Chemosphere, Vol 21, no.12, ppVol. 21, No.12, pp. 1451-1456, 1990.)1990.) According to the report Brominated flame retardants Substance Flow Analysis and Assessment of Alternatives of the Danish EPA (1999), no recycling activities are taking place for materials containing brominated flame retardants.

Environmental problems during the recycling of WEEE are not only linked to halogenated substances. Hazardous emissions to the air also result from the recycling of WEEE containing heavy metals, such as lead and cadmium. These emissions could be significantly reduced through the substitution of the respective materials by less polluting substances in new electrical and electronic equipment and by means of proper pre-treatment of WEEE. Another problem with heavy metals and halogenated substances in untreated WEEE occurs during the shredding process. As in most cases WEEE is shredded without proper disassembly, hazardous substances, such as PCBs contained in capacitors, may be dispersed into the recovered metals and the shredder waste.

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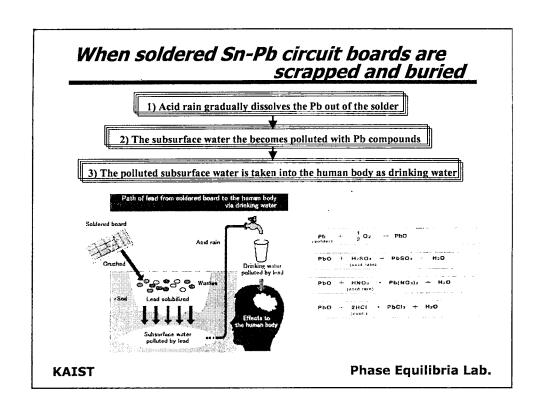
Toxicology of Pb

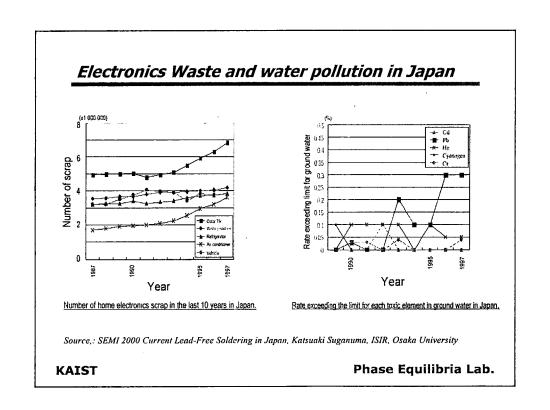
- Environmental, human healthy issue
 - → Pb poisoning 25 mg/dl (micrograms per deciliter)
 - → The influence of Pb on the human body

It has been known for more than a hundred years that Pb affects the human nervous system and cause a range of serious problems. It is reported that the growth rate and intelligence of children that ingest Pb are adversely affected as a results

- Special industrial waste
 - → Waste products formed during the assembly of PCB (solder dross)
 - → Disposal of electronic assemblies

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Worldwide Pb-free Activities

Japanese Pb-free Roadmap

1999 First adoption of Pb-free solders in mass-production goods

2000 Adoption of Pb-free components

Adoption of Pb-free solders in wave soldering

2001 Expansion of use of Pb-free components

Expansion of use of Pb-free solders in new products

2002 General use of Pb-free solders I new products

2003 Full use of Pb-free solders in all new products

2005 Pb-containing solder used only exceptionally.

Source: http://it.jeita.org/jp/jhistory/english/information/pbfree/roadmap.html

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Worldwide Pb-free Activities

SONY 2000/3 Apply Pb-free solder to 1 item min. or each products field 2001/3 Promote to apply Pb-free solder to all items produced in domestic factory
2002/3 Apply Pb-free solder to all items produced in overseas factory

Fujitsu 2000/10 Make all LSI products Pb-free 2001/12 Apply Pb-free solder to half of PCB used in set-products 2002/12 Abolish Pb from all products

Mitsubishi 2001 Promote reduction of Pb in products
2005 Promote to abolish Pb in products

NEC 2001/3 50% Pb solder usage of the 1997 level 2002/12 None of Pb solder

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Japanese Electronics Manufacturing Roadmaps for Pb-free

Manufacturor	Target	Issues	Notes
	ALL	2001	Major 4 products
Panasonic	Compact MD	Oct. 1, 1998	Sn-Ag-Bi-In
Pariasoriic	Cassette tape	Feb., 2000	
	Video Player	1999	Sn-Cu
	Half of 1997	1999	_
Hitachi	All	2001	
	Regrigeratyor	Oct. 1999	Sn-Ag-Bi
NEC	Half of 1997	2002	
NEC	Note PC	Oct. 1999	Sn-Zn-Bi
SONY	Al!	2001	-
SUNY	VCR	Mar. 20, 2000	Sn-Ag-Cu-Bi
Toshiba	Mobile Phones	2000	
Mitsubishi	Half	2004	Major 4 products
MICSUDISTII	All	2005	Major 4 products
	All LSIs	Oct. 2000.	
Fujitsu	Half of PWBs	Dec. 2001	http://www.fujitsu.co.jp
-	Ali	Dec. 2002	
Automobile	Half	2000	Except for battery
Automobile	1/3	2005	Except for Dattery

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Japanese Electronics Manufacturing Roadmaps for Pb-free

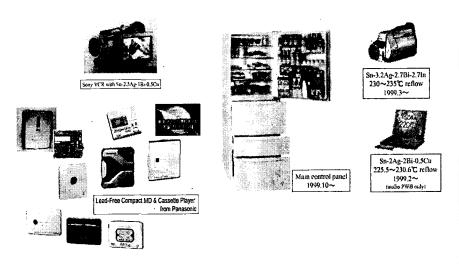
(Updated)

Сопіраву	Action	Target	Products
Panasonic	Complete abolition	March 2003	Mini-disk player, stereo headphone
Sony	Full implementation in Japan	March 2001	Camera, built-in VTR, TV, mini-disk player
	Start lead-free process overseas	March 2002	
litachi	Full implementation for in-house evaluation	March 2002	8mm camera, notebook PC, washing machine
	Complete abolition, except overseas	March 2004	
ÆC	Complete abolition	End, 2002	Pager, notebook
ditsubishi	Establishment of lead-free technology	2002	Refrigerator
lectric	Reduction to half present use	2004	
	Complete abolition	2005	
ujitsu	Reduction to half present use	End 2001	PC, LCD, server
	Full-scale application	End 2002	
ianyo	Produce one lead-free product at each company	March 2001	
	implementation for main products produced in Japan	April 2002	
iharp	Implement for products produced in Japan	April 2001	
	implement for overseas production	April 2002	
ieiko Epson	Complete abolition	End 2001	
Car industry	Reduction to one-third present use, except battery	2005	

Source: Electronic Times http://www.electronictimes.com 2001/03/26

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Worldwide Pb-free Activities



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Worldwide Pb-free Activities

\bullet USA

IPC (Institute of Interconnection, Packaging and Electronic Circuit)'s Activity

"The U.S. electronic interconnection industry, represented by the IPC, uses less than two percent of the world's annual lead consumption. Furthermore, all available scientific evidence and U.S. government reports indicate that the lead used in U.S. printed wiring board manufacturing and electronic assembly produces no significant environmental or health hazards.

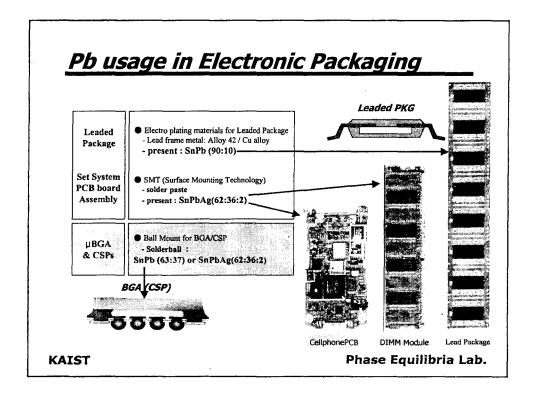
"Nonetheless, in the opinion of IPC, the pressure to eliminate lead in electronic interconnections will continue in the future from both the legislative and competitive sides. IPC encourages and supports research and development of lead-free materials and technologies. These new technologies should provide product integrity, performance and reliability equivalent to lead-containing products without introducing new environmental risks or health hazards. IPC prefers global rather than regional solutions to this issue, and is encouraging a coordinated approach to the voluntary reduction or elimination of lead by the electronic interconnection industry."

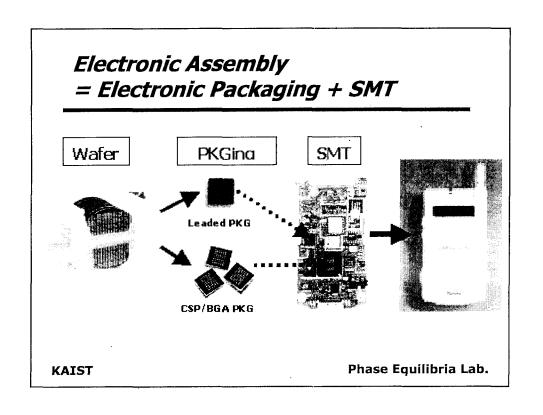
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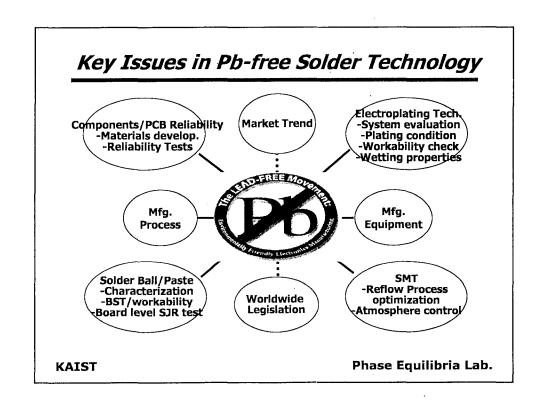
Worldwide Pb-free Activities

- NCMS
 - → Pb-free solder project 1997, 4-year project, 70 Pb-free solders study
- NEMI
 - → North America needs to prepare to deliver Pb-free products by 2001, with an "eye" for toal Pb elimination 2004.
 - → Collaboration with groups such as EIA, IPC and JEDEC
- HDPUG (High Density Package User Group)
- IDEAL (Improved Design Life and Environmentally Aware manufacturing of Electronics Assemblies by Lead-free Soldering)
- ITRI (Tin Research Institutue)
- INNOLOT (Europe-Germany)

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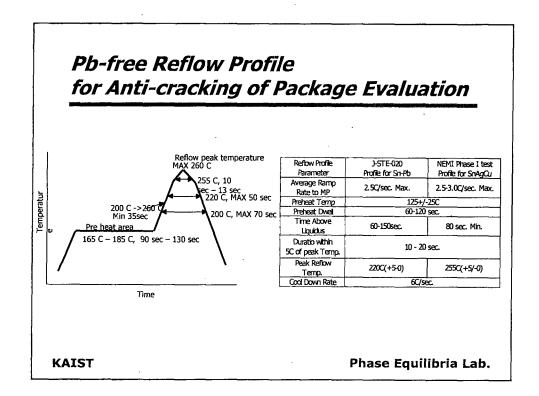




Challenging Items in Pb-free Technology

- Alloy
 - → Alloy section
 - → Material Property Database generation.
 - → Interface w/academia, gov't agencies.
- Components, PCBs
 - → High temperature reflow
 - → Pb-free terminations
- Solder Reliability
 - → Transparent test procedure.
 - → Common data to share with industry.
- Process Development
 - → Generic process for Reliability test boards.

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Challenging of Pb-free Materials

- Pb-free solder ball/ solder paste
 - → SnAgCu NEMI, NCMS etc.
 - → SnAgCuBi SONY (recently changed as SnAgCu)
 - → SnZnX under studying
- Electroplating Systems
 - → PPF (Ni/Pd, Ni/Au)
 - → Pure-Sn
 - → SnBi ; most japanese companies are driving now

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Consideration factor for Pb-free solders

- Melting behavior (Drop-In solution)
- Mechanical properties (Thermo Mechanical)
- Compatible with Pb-containing surface finishes
- Depletion of existing stock of alloys (resource)
- Must work with reflow, wave, hand and rework/repair soldering

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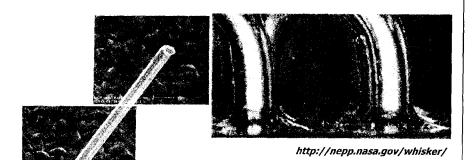
Consideration Factor for Pb-free Electroplating

- Must be compatible with existing high speed plating equipment
- No whisker problem
- Minimum deposition rate of 7.5 microns per minute
- Familiar, preferably MSA electrolyte
- All products in the process must be fully analyzable
- Deposits must possess good solderability (same as/better than Sn-Pb)
- Deposits must possess good ductility (same as/better than Sn-Pb)

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Sn Whisker - Spontaneous single crystal growth



"Spontaneous growth mchanism of Sn whiskers," B.Z. Lee and D. N. Lee, Acta. Mater. Vol.46, No.10, pp.3710-3714 (1998)

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Classification of the Solder Alloys

- Pb-Sn alloys
 - → Ideal properties for the soldering application, melting temperature, large electrical conductivity, good strength and good wettability
- Other solder alloys
 - → Suitability to base metals other than Cu
 - → Special mechanical or physical properties: controlled contraction on freezing, better matched C.T.E, higher strength, better corrosion resistance, better electrical properties
 - → Special applications: fusible links, tooling, step-soldering
 - → CONCERN OVER ENVIRONMENTAL PROTECTION

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Pb-free Solders with Melting Temperature

< Low Melting Temperature : less than 180°C~200°C >

➤ Usually in the 110°C ~ 140°C

➤ Sn-52In: 118°C➤ Sn-58Bi: 138°C➤ Sn-9Zn: 199°C

<Mid-Range Melting Temperature: 200 ~ 230°C>

➤ Sn-3.5Ag: 221°C

ightharpoonup Sn-4.0Ag-0.5Cu : 217 ~ 219°C

➤ Sn-0.7Cu : 227°C

> Sn-2.5Ag-0.8Cu-0.5Sb (Castin): 217 ~ 220°C

<High Temperature: 230 ~ 350°C>

➤ Sn-5Sb: 232 ~ 240°C➤ Sn-80Au: 280°C

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Pb-free Solders with Composition and Melting Temperature

		All	oy Comp	osition (w	/t%)			Tempera	ture (°C)
Sn	In	Ag	Bi	Sb	Zn	Cu	Mg	Ts	TI
48 50	52 50							118 118	- 125
52 58 42	48 42	1						118 118	131 145
42	42		58					138	-
	97	3						143	
	100				9	1		156.7 199	156.7
91 95.5		5			9	4		216	222
96.5		3.5 5				1		221 .	-
95		5						221	240
95 100				5			•	233 232	240 232
100			100	•				271	271
			100					961	961
98		2	ŀ					221 227	226
99.3 90		2	7.5			7 0.5		207	212
98 65			7.5			""	2	200	
65		25 10		10				233	250
16	51	10	90 3					262 61	350
10	66	34	3					166	420
17	26		57					79	
	32 5	ŀ	68		0			109 188	180
86 81	10				9 9			178	
81	10	l		2 ·	7			181	

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Physical Properties of Pb-free Solders

Alloy	CTE (ppm/K)	Density (Kg/m³)	Thermal Conductivity (W/mK)	Surface Tension (mN/m) Air / N ₂
Sn-3.5Ag	22	7360	33	431 / 493
Sn-58Bi	15	8700		319 / 349
Sn-52In	20	7300	34	
In-3Ag	20	7680	73	
Sn-37Pb	25	8400	50	417 / 464
Cu	17	8942	391	
Plastics	6			}
Alloy42	5	8150	14.7	
FR-4	16	1800	35	
Sn-9Zn				518 / 487
Sn-0.7Cu				491 / 461
Sn-5Sb				468 /495

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Physical Properties of Pb-free Solders

Pb 13.1 20.7 Sn 46.9 Ag 82.7 Bi 34.0 31.0 34.0 31.0 13.1 15.59 2.115 32.7 33.0 33.0 33.0	Materials	Young's Modulus	Yield Strength (Mpa)		Shear strength	Strain rate	Resistivity
Sn 46.9 Ag 82.7	riateriais	1	0.2%	0.01%			(? Ω~cm)
In 10.6 Cu 129.6 Sn-58Bi 43 41 26 26 6.2 e-4 34.4 Sn-52In 19.5 Sn-37Pb 30.5 48 36 5n-5Ag Sn-5Ag Sn-5Ag Sn-5OIn Sn-6OIn Alloy42 8.5 3.5 Ag Sn-6OIn Alloy42 8.6 8.62 1.678 8.62 1.678 34.4 14.7 36 6.2 e-4 10 57 10 57 57	Sn Ag Bi In Cu Sn-58Bi Sn-52In Sn-37Pb Sn-3.5Ag Sn-5Ag Sn-5Ag Sn-60In	46.9 82.7 34.0 10.6 129.6 43 19.5	48 34 17	36 27 10	14 36	8.3 e-4 6.2 e-4	10.1 1.59 2.115 8.62 1.678 34.4 14.7 14.4

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Mechanical Properties

• Strength and ductility

Strain rate (s ⁻¹)	Processing (Bulk)	Solder Alloys	UTS (ksi)	Elon g (%)	Ref
1.0*10 ⁻³	5°C/min.cooling	Sn-37Pb	5.8	90	1
1.0*10 ⁻³	5°C/min.cooling	Sn-9Zn	9.4	45	1
1.0*10 ⁻³	5°C/min.cooling	Sn-3.5Ag	6.2	42.5	1
1.0*10 ⁻³	5°C/min.cooling	Sn-3.5Ag-5Bi	10.4	15	1
1.0*10 ⁻³	5°C/min.cooling	Sn-3.5Ag-5In	9.0	20	1
1.0*10 ⁻³	5°C/min.cooling	Sn-3.5Ag-1Zn	8.0	27.5	1
1.0*10 ⁻³	5°C/min.cooling	Sn-3.5Ag-1Zn-0.5Cu	7.0	46	1
1.0*10 ⁻³	5°C/min.cooling	Sn-8Zn-4In	7.3	25	1
1.0*10 ⁻³	5°C/min.cooling	Sn-8Zn-5In-0.1Ag	7.6	40	1
Unspecified	5°C/min.cooling	Sn-20In-2.8Ag	6.8	47	2

1 : M.McCormack et al. 1994

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^{2 :} Indium Corp. patent

• Creep

 \rightarrow dy/dt=A τ ⁿexp(-Q/kT)

 $d\gamma/dt$: strain rate, τ : stress, n: stress exponent, Q : activation energy

Alloys	Temp. (°C)	A	n	Q (kcal/mole)	Ref
Sn-40Pb	20,70,120	0.15	4.52	14.32	3
Sn-3.5Ag	20,75,125	9.3*10 ⁻⁵	6.05	14.61	3
Sn-58Bi	20,75,125	4.04*10 ⁻⁵	3.42	21.85	3
Sn-3.6Ag-1.52Cu	20,75,125	2.6*10 ⁻⁵	3.69	8.6	3
Sn-4.83Bi-3.33Ag	20,75,125	3.0*10 ⁻¹	3.56	11.56	3

• Interfacial fracture

Solder Alloys	Failure (IMC thickness ↑)
Sn-40Pb	Inside the solder → through the IMC
Sn-58Bi	Inside the solder
Sn-3.5Ag	Solder/IMC interface → through the IMC
Sn-3.62Ag-1.52Cu, Sn-4.83Ag-3.33Cu	Solder/IMC interface

3 : D.R.Frear, 1995, 1996

Characteristics of Pb free plating

Material	Composition and Melting temperature	Feature
Sn-Cu	Cu:1.5% 227C	Good mechanical strength Low cost
Sn-Bi	Bi:3.0% 220C	Good stability of plating chemical liquid Low melting temperature Poor mechanical strength with Sn-Pb paste
Sn-Ag	Ag:3.5% 221C	Good mechanical strength High cost
Sn	Sn:100% 232C	Popular for plating Whisker
Pd-Au (pre-plating)	Pd:100% / Au:100% (2 layer) 1552C / 1063C	Difficult to apply 42alloy Fluctuating Pd cost

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Pb-Free Solders vs. Pb-Sn Solders

[Sn-Ag systems]

- > automobile electronic soldering application
- > better thermal fatigue resistance
 - → Sn-3.5Ag-1Zn (217°C): tensile strength ↑, creep deformation ↓
 - → Sn-4.7Ag-1.7Cu (216.8°C), Sn-2Ag-0.8Cu (210-216°C)
 - → Sn-3.5Ag-(≤6%)Bi (211-221°C): single phase transition
 - → Sn-(1-6%)Ag-(4-35%)In (167.9-179°C, 212-213.5°C)

Sn-Ag-Cu systems

- ➤ Sn-4.7Ag-1.7Cu: 216-218°C, AMES labs
- > Sn-4.0Ag-1Cu: 217-219°C, AMES labs
- > Sn-3.0Ag-0.5Cu: Harris Brazing Co.
- > Sn-4.0Ag-0.5Cu: 217-219°C, unpatentable
- > Sn-3.8Ag-0.7Cu: 217-219°C, unpatentable
- > Sn-3.2Ag-0.5Cu: 217-218°C, unpatentable
- > Sn-3.5Ag-0.75Cu : Senju
- > Sn-0.7Cu: 227°C, Poorest in Mechanical properties

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Sn-Ag-Cu-X

- > Sn-2.5Ag-0.8Cu-0.5Sb: 9213-218°C, Castin Alloy
- > International Tin Research Inst., Lucent, Ford, and Sandia Labs.
- ➤ Sn-2Cu-0.8Sb-0.2Ag, Sn-Ag-Cu-In: Promising

• Sn-Ag-Bi-X

- ➤ Addition of <5wt%Bi: wettablility ↑
- > Indium Corp. Matsushita
- ➤ Sn-3.5Ag-4.8Bi : 202-215°C, Sandia Labs., NCMS-> most promising
- \blacktriangleright Sn-3.5Ag-3Bi ; 210-217°C, Tamura Handa
- ➤ Sn-7.5Bi-2Ag: 191-210°C, Tamura Kaken
- > Sn-Ag-Bi : Matsushita
- ➤ Sn-3Ag-3Bi : 213°C
- ➤ Sn-3Ag-5Bi : 210°C
- ➤ Sn-3.2Ag-3Bi-1.1Ci-Ge : Japan Solder
- > Sn-3.5Ag-0.5Bi-3In : Harima, Mitsui Metals
- ➤ Sn-2Ag-7.5Bi-0.5Cu : Alloy H, Alpha Metals, developed at ITRI
- ➤ Sn-(2.0-2.8)Ag-(13-17)Bi-(0-1)Cu : Hitachi
- ➤ Sn-2.8Ag-10Bi-0.6Cu: Ono

>> Sn-Ag-3Bi : 210°C, Matsushita
 >> Sn-Ag-6Bi : 220°C, Matsushita
 >> Sn-Ag-10Bi : 205°C, Matsushita
 >> Sn-Ag-15Bi : 209°C, Matsushita

[Sn-Sb & Sn-Sb-Pb systems]

- > stronger
- > improved creep strength
- > narrow melting range
- > toxicity of Sb

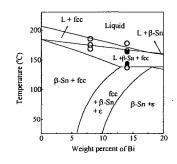
[Sn-Zn-X systems]

> Sn-9Zn: 199°C, reactive
> Sn-8Zn-3Bi: Japan
> Sn-9Zn-1In: AT&T

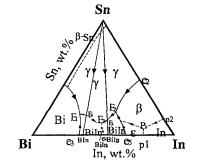
➤ Sn8Zn-3Bi: 191-195°C, Matsushita, Senju
 ➤ Sn-Zn-Bi-X: Hitachi Harima, Tamura

Design of Pb-free Solder Alloy

- Low Melting Temperature Solder
 - → ternary Sn-Bi-Pb system
 - → ternary Sn-Bi-In system

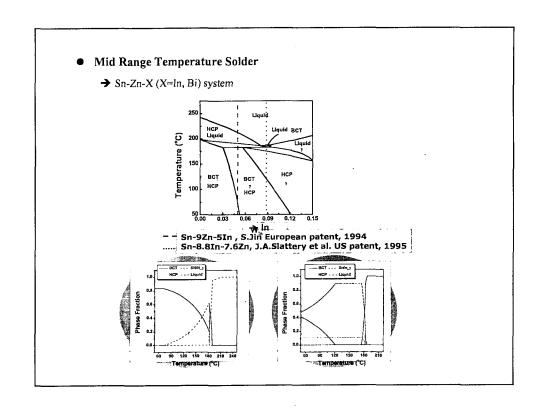


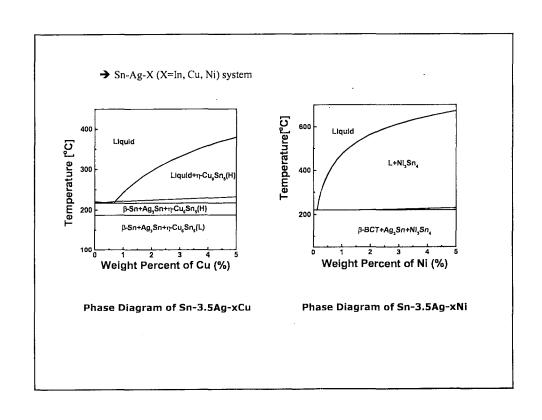
Vertical phase diagram calculated along a constant amount of 43% Bi.



Liquidus Projection of ternary Sn-Bi-In system

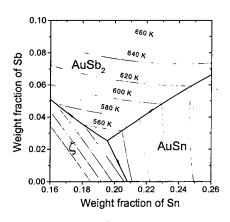
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• High Temperature Solder

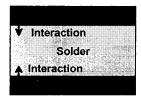
→ Au-Sn-Sb system

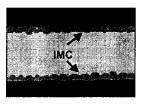


The ternary eutectic part of calculated Au-Sb-Sn ternary system

Base Metal/Solder Interactions

- During reflow processes, base metal and solder interact to form intermetallic compound (IMC).
- In service, IMC grows.
- IMC may result in the deterioration of the solder reliability.







< During Wetting >

< In Service >

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Intermetallics

- IMC formation during reflow
 - > Reaction between the molten solder and the substrate
 - → Dissolution of substrate into the molten solder
 - → Solubility of the active element in the solder in the substrate
 - > Duration time above the solder's liquidus temperature
 - > Lead to loss of strength under certain loading condition
- Physical properties of IMC (at RT)

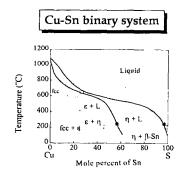
Property	Cu,Sn,	Cu ₃ Sn	Ni ₃ Sn ₄	
Vickers Hardness (kg/mm²)	378±55	343±47	365±7	
Toughness (MPa m 12)	1.4±0.3	1.7±0.3	1.2±0.1	
Young's Modulus (GPa)	85.56±1/65	108.3 ± 4.4	133.3±5.6	
Shear Modulus (GPa)	50.21	42.41	45.0	
Thermal Expansion (x10%)	16.3±0.3	19.0±0.3	13.7±0.3	
Thermal Diffusivity (cm²/sec)	0.145±0.015	0.24±0.024	0.083 ± 0.008	
Resistivity (μΩcm)	17.5 ± 0.1	8.93 ± 0.02	28.5±0.1 .	

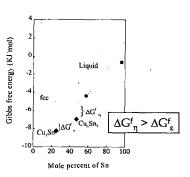
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Phase Equilibria Lab.

Prediction of Interface Reaction Products

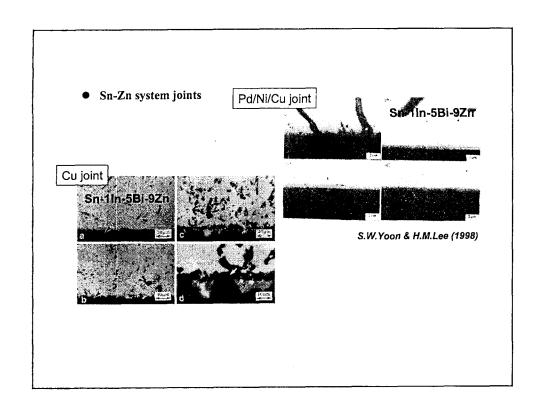
- Thermodynamic state at the interface between the liquid solder and the substrate
 - → by calculating metastable equilibria between the initial phases
- The first forming Intermetallic phase
 - → highest driving force under the metastable equilibrium

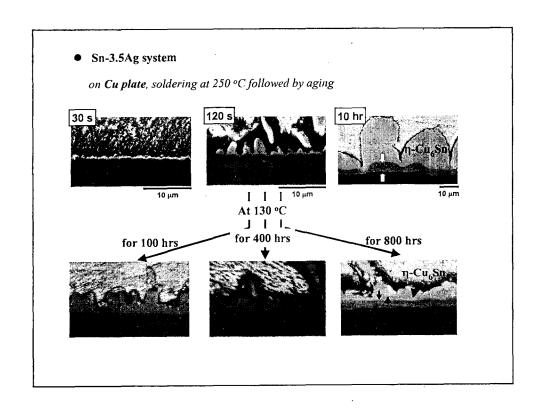


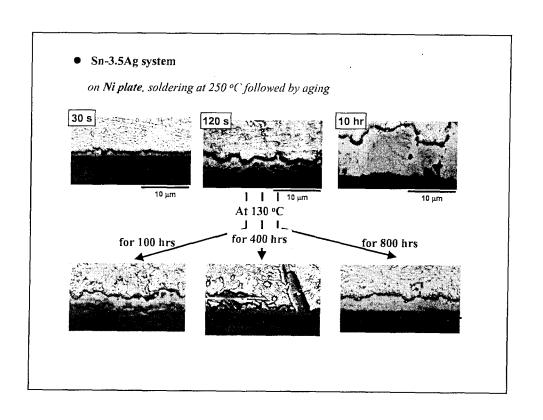


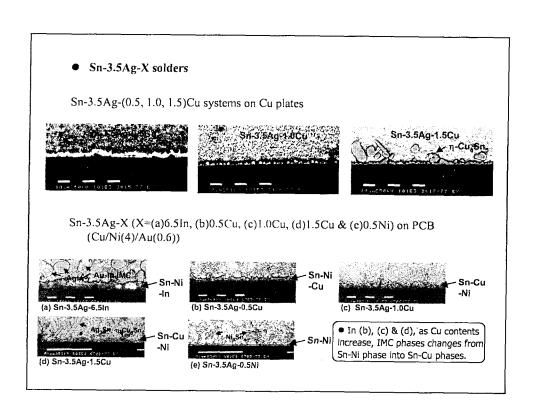
• This can be applied to the ternary system, solder/Cu.

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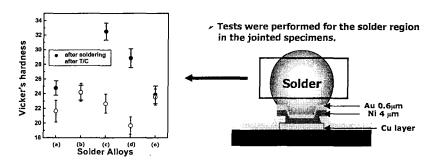






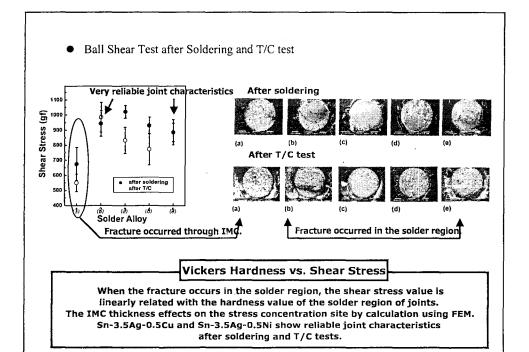
Solder Joint Reliability

• Micro Hardness Test after Soldering and T/C test



(a) Sn-3.5Ag-6.5In, (b) Sn-3.5Ag-0.5Cu, (c) Sn-3.5Ag-1.0Cu, (d) Sn-3.5Ag-1.5Cu and (e) Sn-3.5Ag-0.5Ni

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Roadblock for Pb-free Transition

- Lack of global-agreed system requirements
- Component temperature durability
- Lack of reliable data and knowledge from field use
- Insufficient data about the environmental impact of Pb-free alternatives
- No single drop in Pb-free solution exists. Severe compatibility
- Additional technical roadblocks maybe identified when materials systems are defined
- No agreement on test specification and methods

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Phase Equilibria Lab.

Future works need.....

- Portable more sensitive to Pb-free issues
- Environmental is becoming essential electronics equipment
- Earth-friendly material need
- Mass production
- → Eco-Ages → Safe Materials
 - → Green Market Economy (green consumer)
- More works on
 - > recycling or combustion disposal
 - > Halogen/Antimony free
 - > New environmental materials

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Summary

- EC's/Japanese environmental regulation drive the Pb-free/Halogen-free application
- Most Japanese electronics companies are preparing the green products.
- All items concerning to Pb-free/Halogen-ree technology should be coparallely designed and developed.
- More works need to clear the unknowns on Pb-free materials
- Need of consensus on materials and standards
- EBM (Environmental Benign Manufacturing)

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